	207 5	TMC SPECIFICATION NO. S-778	B
BDV COMMLED	CHECKED	TITLE:	
APPR	OVED PAL		

AX-432 TEST PROCEDURE (RF MODULE VLR-1)

DATE 15 Ja	or 5	TMC SPECIFICATION NO. S -778	E
RDV COMPILED	CHECKED	TITLE: AX-432 TEST PROCEDURE	
APPF	ROVED	(RF MODULE VLR-1)	

## I. TEST EQUIPMENT

- 1. Signal Generator TF 114 H MARCONI INSTRUMENTS, LTD., or equivalent.
- 2. TEKTRONIX SCOPE Type 545 A, Type "L" plug-in unit or equivalent.
- 3. A-C BALLANTINE Voltmeter- 314 or equivalent.
- 4. HP VTVM Model 410B or equivalent.
- 5. RF Attenuation Box TELONIC Model TG 950(50 ohm to 50 ohm) or equivalent.
- 6. Two Power Supplies (12V) HARRISON LABS #855B or equivalent.
- 7. Test Jig (see illustration on Page 4).
- 8. HP Counter Model 524C or equivalent.

# II. PRELIMINARY

- 1. Inspect the unit for mechanical imperfections such as loose screws, printed circuit board, cold solder joints etc.
- 2. Connect the Test Jig to the RF Module

#### III. LOCAL CRYSTAL OSCILLATOR

- 1. Connect the A-C meter to pin 2 of connector and GND.
- 2. Turn the test jig on and read approx. 600 MV on the A-C meter.
- 3. Select a 1/2 watt resistor between the values of 1.2K to 8.2K which, when inserted tato the R219 position, will result in a reading of 150 MV<sup>±</sup>10.MV
- 4. Solder R219 to the printed circuit board.

# IV. 1st, 2nd, and 3rd RF AMPLIFIERS

- 1. Remove the crystal temporarily.
- 2. Connect the counter to the signal generator.
- 3. Inject 1.uv at the operating frequency ±2 cps of the RF Module into the test jig RF in jack.
- 4. Tune T201, T203, and T204 for a peak reading on the A-C meter.
- 5. The tuning of each successive stage in Step #4 will have an effect on the preceding stage. Because of this, repeat Step #4 until the maximum peak reading on the A-C meter is obtained. This reading should be a minimum of 40MV.

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## V. BANDWIDTH

1. Increase the input signal to 10 uv.

2. Vary the frequency of the Signal Generator above and below the center frequency until the A-C meter reads -3db below the center frequency reading.

3. The difference between the higher and the lower frequency in Step #2 is the bandwidth of the RF amplifier and should be 140 cps±60 cps.

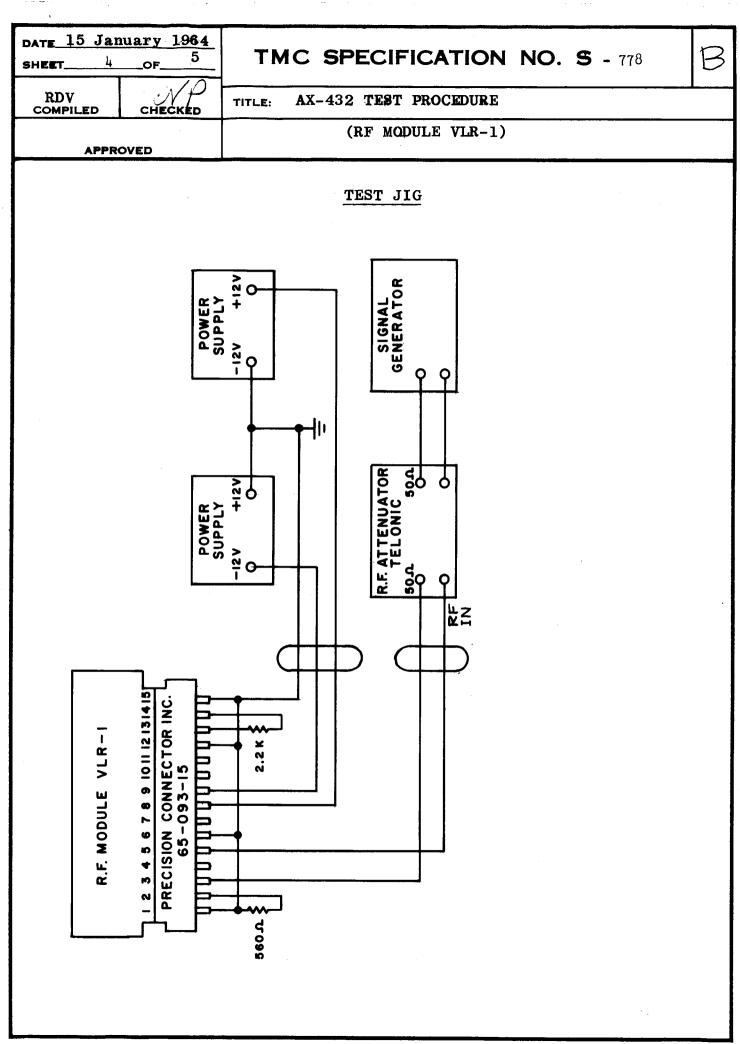
### VI. TRF OUTPUT

- 1. Inject 10 uv, at the operating frequency  $\pm 2$  cps of the RF module into the test jig RF 1N jack.
- 2. Connect the A-C voltmeter to pin 2 of connector and GND and read a minimum of 3MV.

### VII. NOISE SILENCER

- 1. Connect the A-C voltmeter to PIN #10 on the connector, and GND.
- 2. With the same input as in Step #1 of Paragraph VI, read  $50~\text{MV}^{\pm}30~\text{MV}$ .
- 3. Reinsert the crystal into the crystal holder.

This concludes the production testing of the RF Module.



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APPR	OVED	(RF MODULE VLR-1)	
	7	THE TECHNICAL MATERIEL CORPORATION MAMARONECK, N.Y.	
	<b>AX</b> -4	32 TEST DATA SHEET (VLR-1 RF MODULE)	
MFG. N	o	·	
II. 1.	Mechanical Wiring che	check OK	
III. 2.	Local cry	rstal oscillator output (150 MV <sup>±</sup> 10 MV)	MV.
IV. 4.	RF OUTPUT	for 1. dv. input (Minimum 40MV)	MV.
v. 3.	Bandwidth	at 3db should be(140 cps±60 cps)	
VI. TR	F output fo	r 10 uv. input (Minimum 3MV.	MV.
VII. No	ise silence	er output for 10 uv. input(50 MV±30 MV)	MV.
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DATE		·	
TESTER	,		

8444

REVISION SHEET			THE TECHNICAL MATERIEL CORP. MAMARONECK NEW YORK LIST NO.			
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